

**Amplifier, Power, 1 W
2-18 GHz**

MAAPGM0080-DIE
Rev -
Preliminary Datasheet

Features

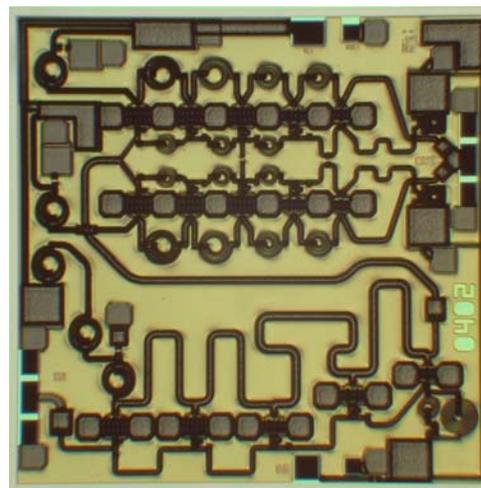
- ◆ **1 Watt Saturated Output Power Level**
- ◆ **Variable Drain Voltage (6-10V) Operation**
- ◆ **MSAG[®] Process**

Description

The MAAPGM0080-DIE is a 2-stage 1 W distributed power amplifier with on-chip bias networks. This product is fully matched to 50 ohms on both the input and output. It can be used as a power amplifier stage or as a driver stage in high power applications.

Fabricated using M/A-COM's repeatable, high performance and highly reliable GaAs Multifunction Self-Aligned Gate (MSAG[™]) Process, each device is 100% RF tested on wafer to ensure performance compliance.

M/A-COM's MSAG[™] process features robust silicon-like manufacturing processes, planar processing of ion implanted transistors, multiple implant capability enabling power, low-noise, switch and digital FETs on a single chip, and polyimide scratch protection for ease of use with automated manufacturing processes. The use of refractory metals and the absence of platinum in the gate metal formulation prevents hydrogen poisoning when employed in hermetic packaging.



Primary Applications

- ◆ **Electronic Warfare**
- ◆ **Ultra Wideband (UWB)**
- ◆ **Test Instrumentation**

Also Available in:

Description	SAMPLES		
	Plastic	Sample Board (Die)	Mechanical Sample (Die)
Part Number	MAAP-000080-PKG003	MAAP-000080-SMB004	MAAP-000080-MCH000

Electrical Characteristics: $T_B = 10^\circ C^1$, $Z_0 = 50\Omega$, $V_{DD} = 10V$, $I_{DQ} = 750mA^2$, $P_{in} = 22\text{ dBm}$, $R_G = 130\Omega$

Parameter	Symbol	Typical	Units
Bandwidth	f	2.0-18.0	GHz
Output Power	P_{OUT}	30	dBm
1-dB Compression Point	P_{1dB}	29.5	dBm
Small Signal Gain	G	11.5	dB
Power Added Efficiency	PAE	11	%
Input VSWR	VSWR	1.5:1	
Output VSWR	VSWR	1.8:1	
Gate Current	I_{GG}	5	mA
Drain Current	I_{DD}	800	mA

1. T_B = MMIC Base Temperature
2. Adjust V_{GG} between -2.6 and -1.2V to achieve specified I_{dq} .

Maximum Ratings³

Parameter	Symbol	Absolute Maximum	Units
Input Power	P_{IN}	27.0	dBm
Drain Supply Voltage	V_{DD}	+12.0	V
Gate Supply Voltage	V_{GG}	-3.0	V
Quiescent Drain Current (No RF)	I_{DQ}	0.78	A
Quiescent DC Power Dissipated (No RF)	P_{DISS}	7.8	W
Junction Temperature	T_J	170	°C
Storage Temperature	T_{STG}	-55 to +150	°C

3. Operation beyond these limits may result in permanent damage to the part.

Recommended Operating Conditions⁴

Characteristic	Symbol	Min	Typ	Max	Unit
Drain Voltage	V_{DD}	6.0	10.0	10.0	V
Gate Voltage	V_{GG}	-2.6	-2.0	-1.2	V
Input Power	P_{IN}		22.0	25.0	dBm
Thermal Resistance	Θ_{JC}		13.1		°C/W
MMIC Base Temperature	T_B			Note 5	°C

4. Operation outside of these ranges may reduce product reliability.

5. MMIC Base Temperature = 170°C — $\Theta_{JC} * V_{DD} * I_{DQ}$

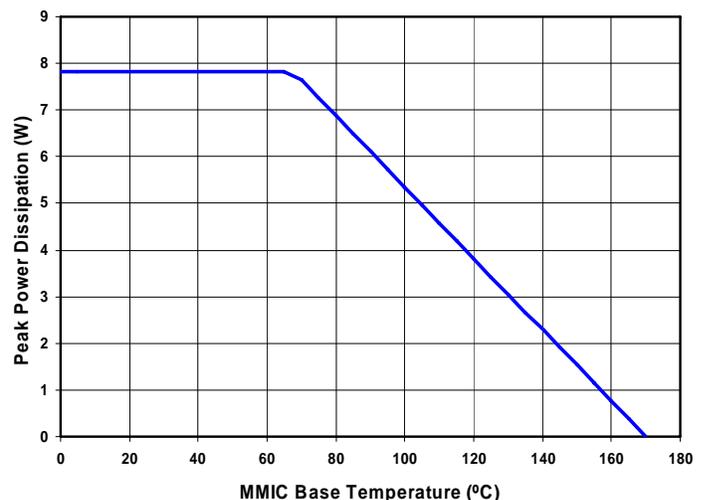


Operating Instructions

This device is static sensitive. Please handle with care. To operate the device, follow these steps.

1. Apply $V_{GG} = -2.7$ V, $V_{DD} = 0$ V.
2. Ramp V_{DD} to desired voltage, typically 10.0 V.
3. Adjust V_{GG} to set I_{DQ} , (approximately @ -2.0 V).
4. Set RF input.
5. Power down sequence in reverse. Turn V_{GG} off last.

Power Derating Curve, Quiescent (No RF)



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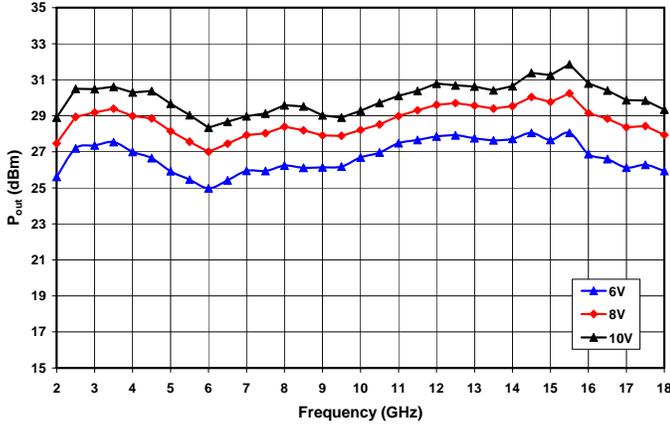


Figure 1. Output Power and Power Added Efficiency at $P_{in} = 22\text{dBm}$, and $I_{DSQ}=740\text{mA}$

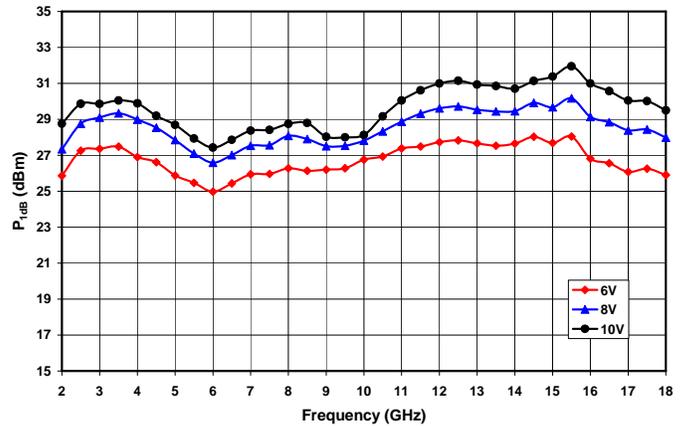


Figure 2. 1dB Compression Point and Drain Voltage at $I_{DSQ}=750\text{mA}$

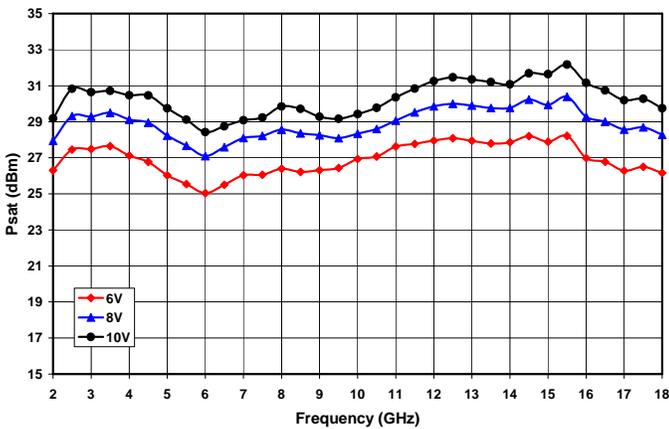


Figure 3. Saturated Output Power vs. Frequency and Drain Voltage

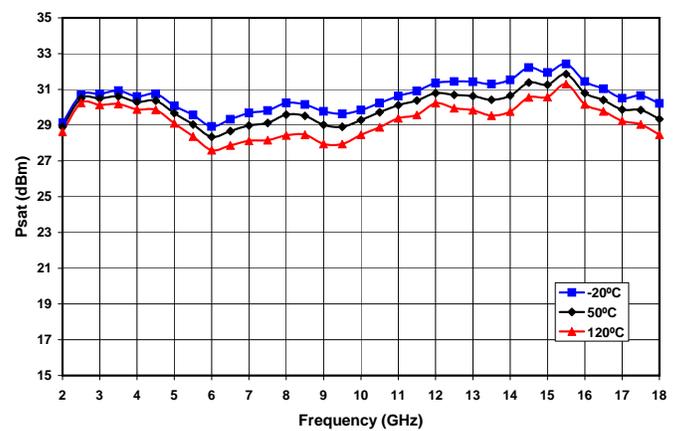


Figure 4. Saturated Output Power vs. Frequency and Temperature at $V_D=10\text{V}$ and $I_{DSQ}=750\text{mA}$.

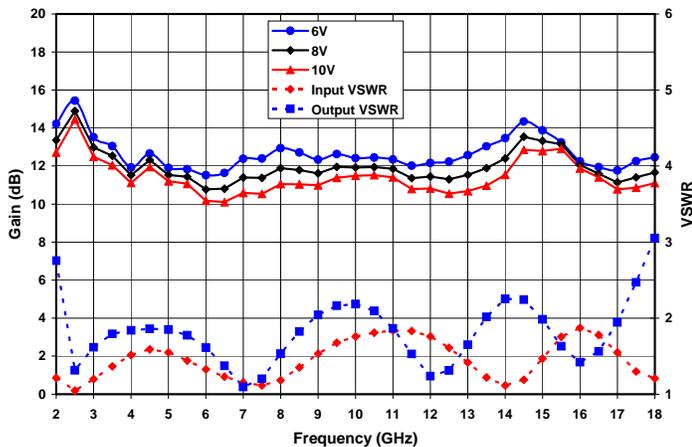


Figure 5. Small Signal Gain and Input and Output VSWR at $I_{DSQ}=750\text{mA}$.

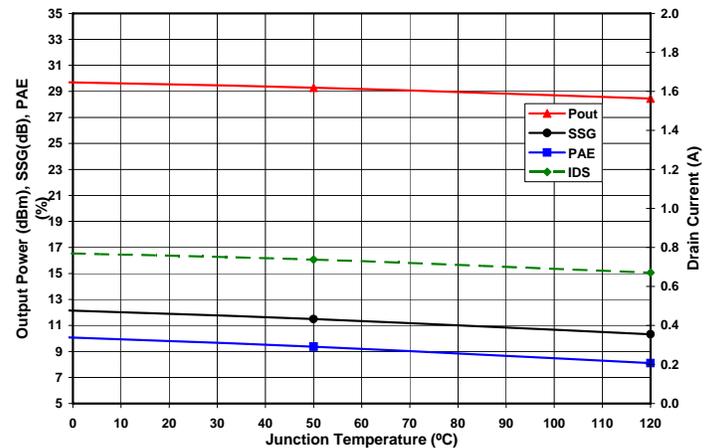


Figure 6. Output Power, Small Signal Gain, Power Added Efficiency, and Drain Current vs. Junction Temperature at 10V, 10GHz, and 750mA.

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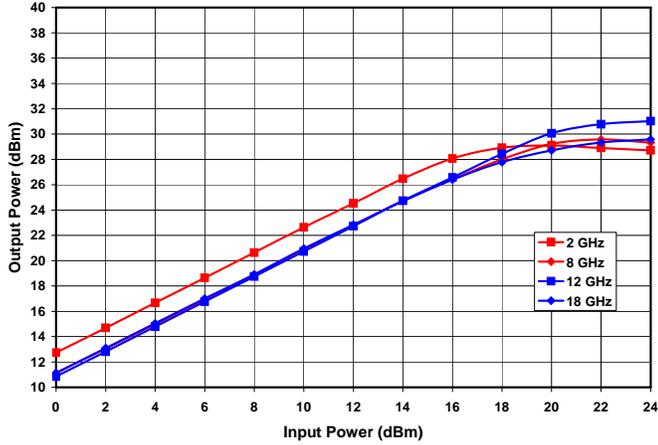


Figure 7. Output Power vs. Input Power and Frequency at 10V and 750mA

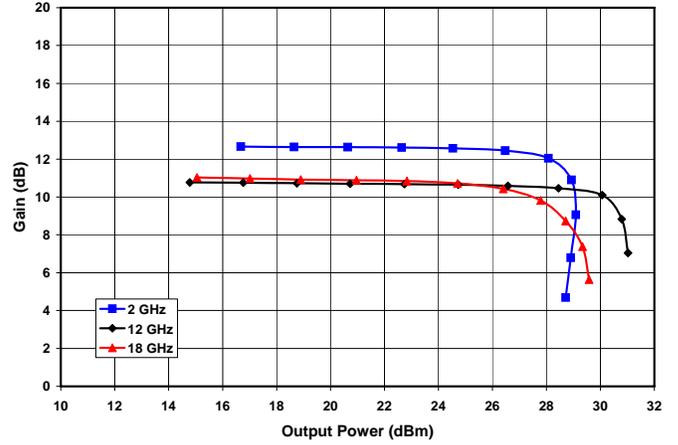


Figure 8. Gain vs. Output Power and Frequency at 10V and 750mA.

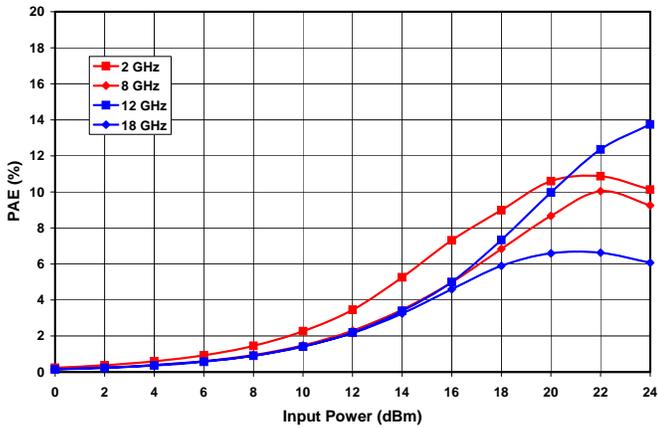


Figure 9. Power Added Efficiency vs. Input Power and Frequency at 10V and $I_{DC}=750mA$.

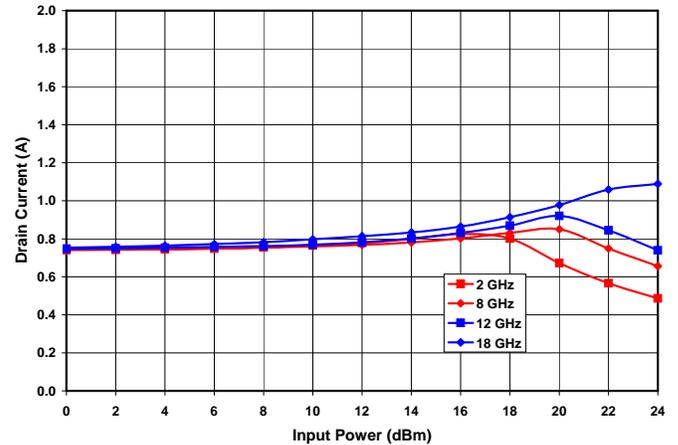


Figure 10. Drain Current vs. Input Power and Frequency at 10V and 750mA.

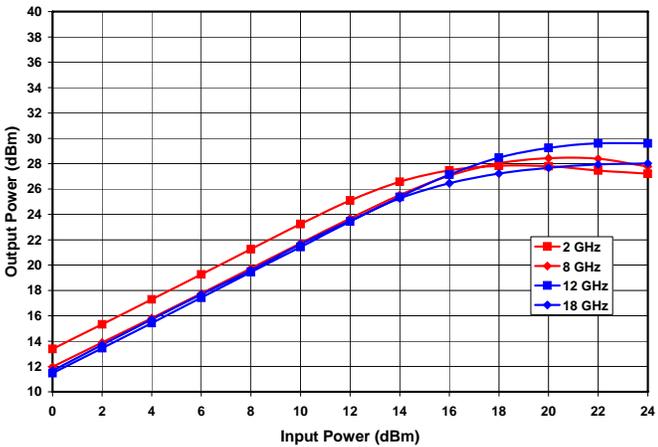


Figure 11. Output Power vs. Input Power and Frequency at 8V and 750mA.

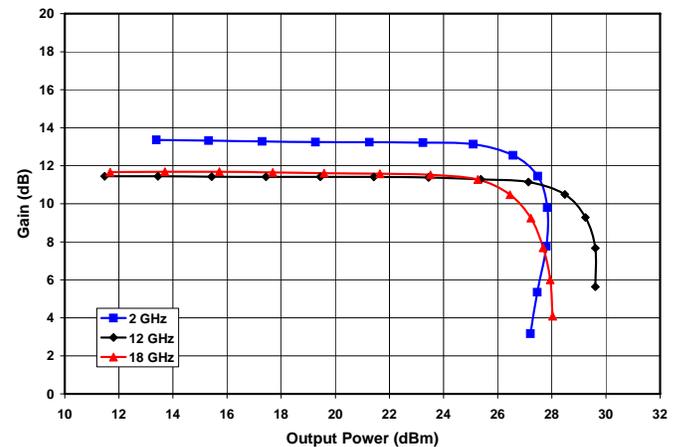


Figure 12. Gain vs. Output Power and Frequency at 8V and 750mA.

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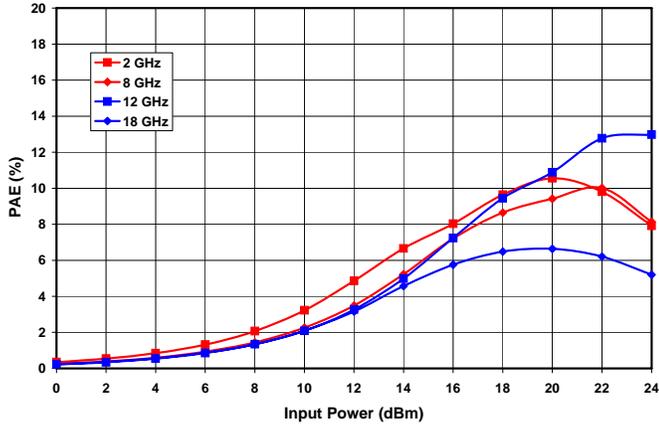


Figure 13. Power Added Efficiency vs. Input Power and Frequency at 8V and $I_{DSQ}=750mA$.

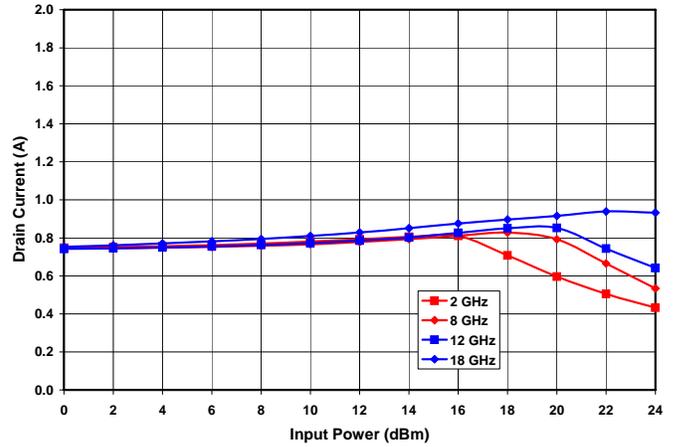
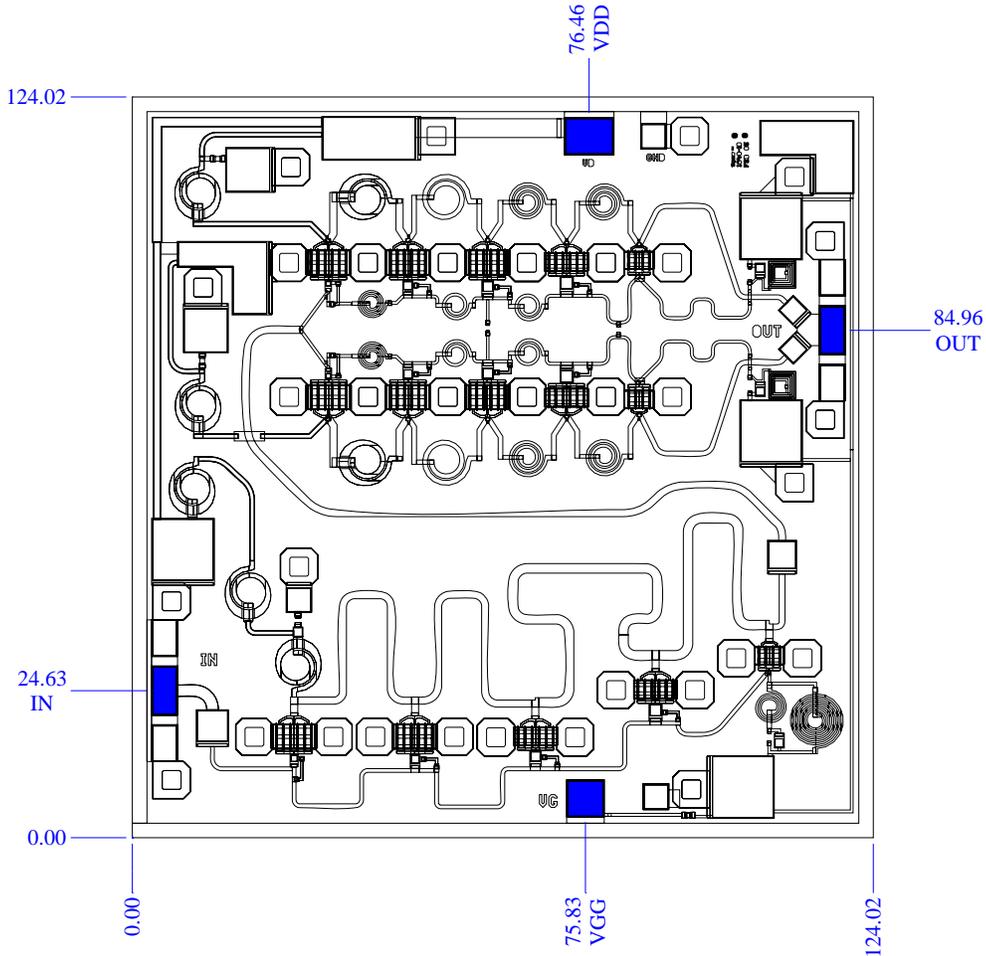


Figure 14. Drain Current vs. Input Power and Frequency at 8V and 750mA

Mechanical Information

Chip Size: 3.150 x 3.150 x 0.075 mm (124 x 124 x 3 mils)



Chip edge to bond pad dimensions are shown to the center of the bond pad (mils).

Figure 1. Die Layout

Bond Pad Dimensions

Pad	Size (µm)	Size (mils)
RF In and Out	100 x 200	4 x 8
DC Drain Supply Voltage VDD	200 x 150	8 x 6
DC Gate Supply Voltage VGG	150 x 150	6 x 6

Assembly and Bonding Diagram

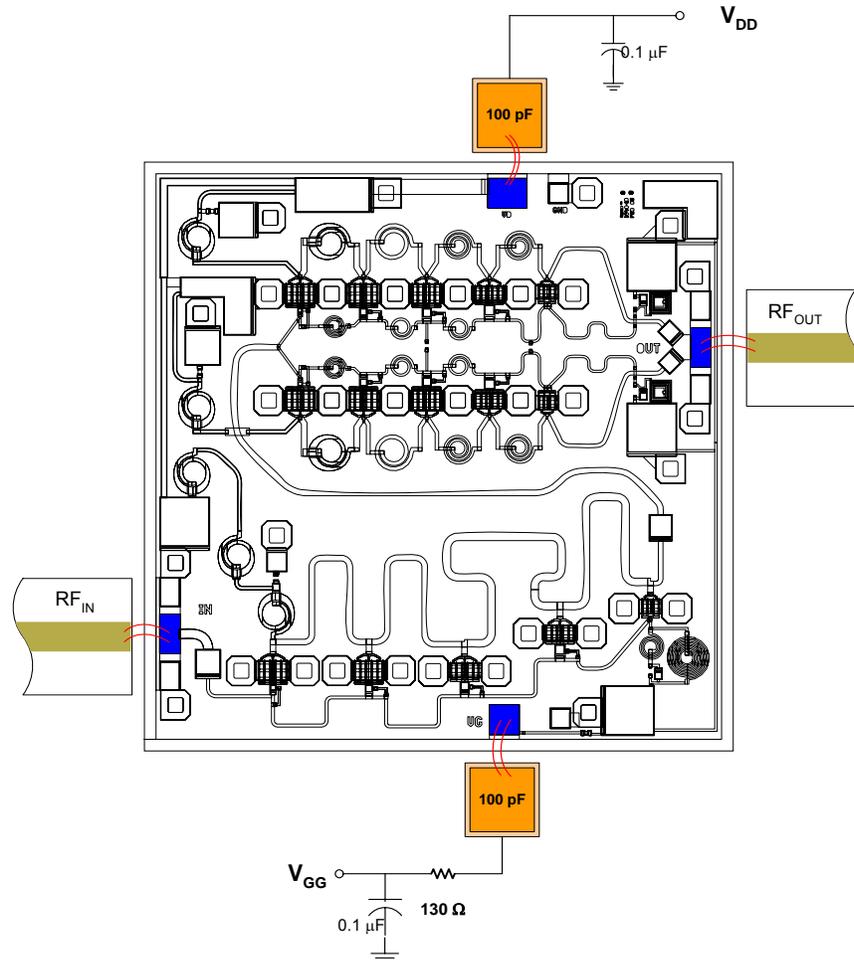


Figure 2. Recommended operational configuration. Wire bond as shown.

Assembly Instructions:

Die attach: Use AuSn (80/20) 1 mil. preform solder. Limit time @ 300 °C to less than 5 minutes.

Wirebonding: Bond @ 160 °C using standard ball or thermal compression wedge bond techniques. For DC pad connections, use either ball or wedge bonds. For best RF performance, use wedge bonds of shortest length, although ball bonds are also acceptable.

Biasing Note: Must apply negative bias to V_{GG} before applying positive bias to V_{DD} to prevent

